

# RF Power Field Effect Transistors

## N-Channel Enhancement-Mode Lateral MOSFETs

Designed for GSM and GSM EDGE base station applications with frequencies from 1930 to 1990 MHz. Suitable for TDMA, CDMA, and multicarrier amplifier applications.

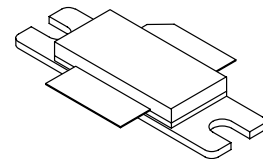
- GSM and GSM EDGE Performance, Full Frequency Band (1930 - 1990 MHz)  
Power Gain - 12.5 dB (Typ) @ 85 Watts CW  
Efficiency - 50% (Typ) @ 85 Watts CW
- Capable of Handling 5:1 VSWR, @ 26 Vdc, 1960 MHz, 85 Watts CW Output Power

### Features

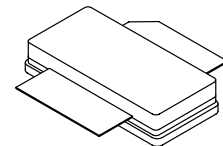
- Internally Matched for Ease of Use
- High Gain, High Efficiency, and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Available with Low Gold Plating Thickness on Leads. L Suffix Indicates 40μ" Nominal.
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

**MRF18085BLR3**  
**MRF18085BLSR3**

**1930-1990 MHz, 85 W, 26 V**  
**GSM/GSM EDGE**  
**LATERAL N-CHANNEL**  
**RF POWER MOSFETs**



**CASE 465-06, STYLE 1**  
**NI-780**  
**MRF18085BLR3**



**CASE 465A-06, STYLE 1**  
**NI-780S**  
**MRF18085BLSR3**

**Table 1. Maximum Ratings**

| Rating                                                                                 | Symbol    | Value        | Unit                     |
|----------------------------------------------------------------------------------------|-----------|--------------|--------------------------|
| Drain-Source Voltage                                                                   | $V_{DS}$  | -0.5, +65    | Vdc                      |
| Gate-Source Voltage                                                                    | $V_{GS}$  | -0.5, +15    | Vdc                      |
| Total Device Dissipation @ $T_C = 25^\circ\text{C}$<br>Derate above $25^\circ\text{C}$ | $P_D$     | 273<br>1.56  | W<br>W/ $^\circ\text{C}$ |
| Storage Temperature Range                                                              | $T_{stg}$ | - 65 to +150 | $^\circ\text{C}$         |
| Case Operating Temperature                                                             | $T_C$     | 150          | $^\circ\text{C}$         |
| Operating Junction Temperature                                                         | $T_J$     | 200          | $^\circ\text{C}$         |

**Table 2. Thermal Characteristics**

| Characteristic                       | Symbol          | Value <sup>(1)</sup> | Unit                      |
|--------------------------------------|-----------------|----------------------|---------------------------|
| Thermal Resistance, Junction to Case | $R_{\theta JC}$ | 0.79                 | $^\circ\text{C}/\text{W}$ |

1. Refer to AN1955/D, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>.  
Select Documentation/Application Notes - AN1955.

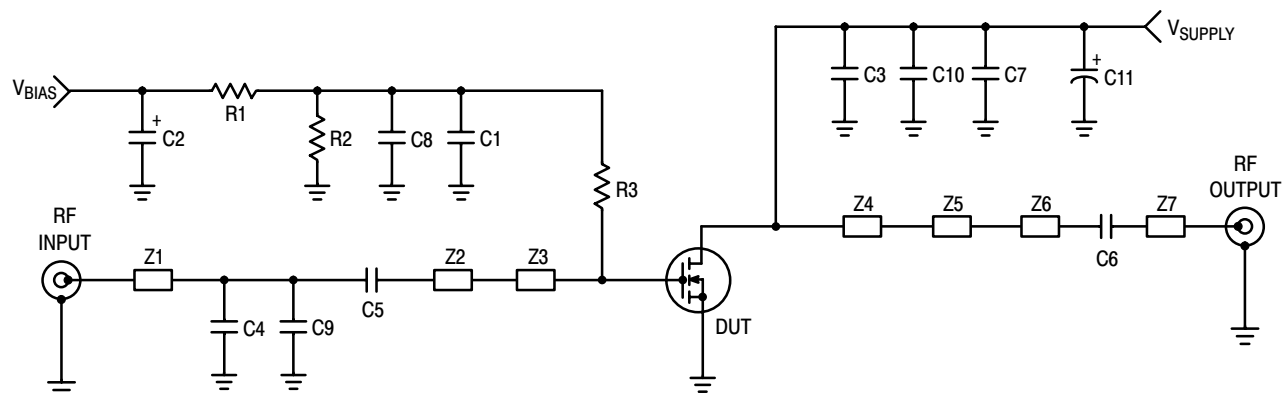
**Table 3. ESD Protection Characteristics**

| Test Conditions  | Class        |
|------------------|--------------|
| Human Body Model | 1 (Minimum)  |
| Machine Model    | M3 (Minimum) |

**Table 4. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

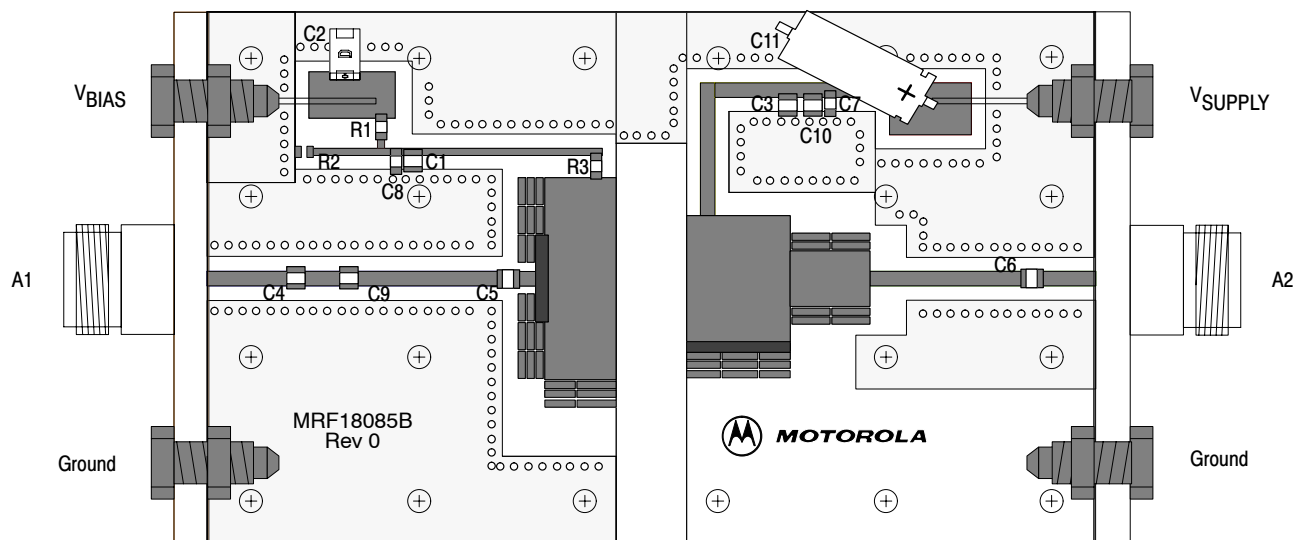
| Characteristic                                                                                                                      | Symbol        | Min  | Typ  | Max  | Unit            |
|-------------------------------------------------------------------------------------------------------------------------------------|---------------|------|------|------|-----------------|
| <b>Off Characteristics</b>                                                                                                          |               |      |      |      |                 |
| Drain-Source Breakdown Voltage<br>( $V_{GS} = 0\text{ Vdc}$ , $I_D = 100\text{ }\mu\text{Adc}$ )                                    | $V_{(BR)DSS}$ | 65   | —    | —    | Vdc             |
| Zero Gate Voltage Drain Current<br>( $V_{DS} = 26\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )                                           | $I_{DSS}$     | —    | —    | 10   | $\mu\text{Adc}$ |
| Gate-Source Leakage Current<br>( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )                                                | $I_{GSS}$     | —    | —    | 1    | $\mu\text{Adc}$ |
| <b>On Characteristics</b>                                                                                                           |               |      |      |      |                 |
| Gate Threshold Voltage<br>( $V_{DS} = 10\text{ Vdc}$ , $I_D = 200\text{ }\mu\text{Adc}$ )                                           | $V_{GS(th)}$  | 2    | —    | 4    | Vdc             |
| Gate Quiescent Voltage<br>( $V_{DS} = 26\text{ Vdc}$ , $I_D = 600\text{ mAdc}$ )                                                    | $V_{GS(Q)}$   | 2.5  | 3.9  | 4.5  | Vdc             |
| Drain-Source On-Voltage<br>( $V_{GS} = 10\text{ Vdc}$ , $I_D = 2\text{ Adc}$ )                                                      | $V_{DS(on)}$  | —    | 0.18 | 0.21 | Vdc             |
| <b>Dynamic Characteristics</b>                                                                                                      |               |      |      |      |                 |
| Reverse Transfer Capacitance (1)<br>( $V_{DS} = 26\text{ Vdc}$ , $V_{GS} = 0$ , $f = 1\text{ MHz}$ )                                | $C_{rss}$     | —    | 3.6  | —    | pF              |
| <b>Functional Tests</b> (In Freescale Test Fixture, 50 ohm system)                                                                  |               |      |      |      |                 |
| Common-Source Amplifier Power Gain @ 85 W<br>( $V_{DD} = 26\text{ Vdc}$ , $I_{DQ} = 800\text{ mA}$ , $f = 1930 - 1990\text{ MHz}$ ) | $G_{ps}$      | 11.5 | 12.5 | —    | dB              |
| Drain Efficiency @ 85 W<br>( $V_{DD} = 26\text{ Vdc}$ , $I_{DQ} = 800\text{ mA}$ , $f = 1930 - 1990\text{ MHz}$ )                   | $\eta$        | 46   | 50   | —    | %               |
| Input Return Loss @ 85 W<br>( $V_{DD} = 26\text{ Vdc}$ , $I_{DQ} = 800\text{ mA}$ , $f = 1930 - 1990\text{ MHz}$ )                  | IRL           | —    | -12  | -9   | dB              |
| P1 dB Output Power<br>( $V_{DD} = 26\text{ Vdc}$ , $I_{DQ} = 800\text{ mA}$ , $f = 1930 - 1990\text{ MHz}$ )                        | P1dB          | 80   | 90   | —    | W               |

1. Part is internally matched both on input and output.



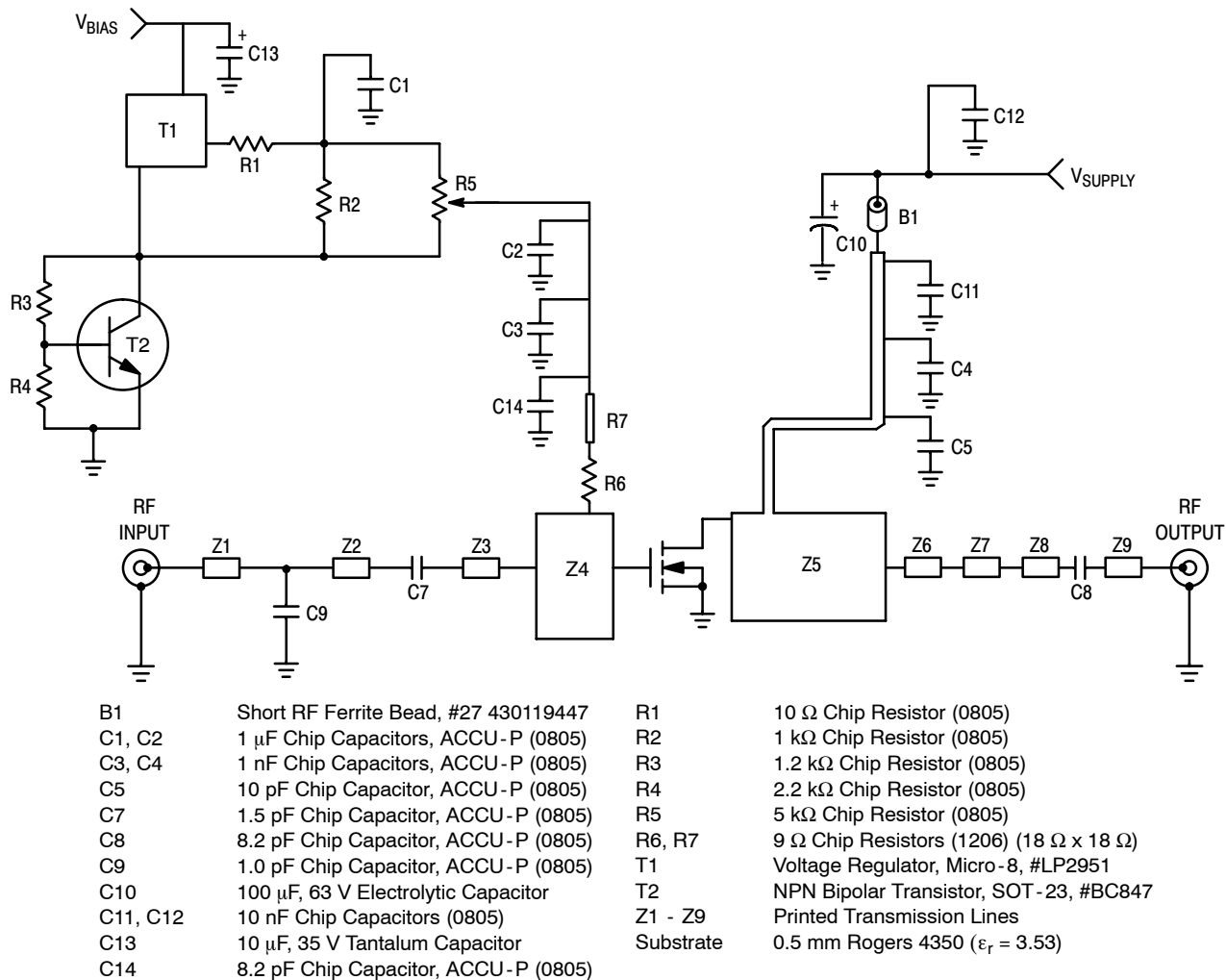
|         |                                          |     |                                                          |
|---------|------------------------------------------|-----|----------------------------------------------------------|
| C1, C10 | 1.0 nF Chip Capacitors, ATC              | Z1  | 1.654" x 0.082" Microstrip                               |
| C2      | 10 $\mu$ F, 35 V Tantalum Capacitor      | Z2  | 0.207" x 0.082" Microstrip                               |
| C3, C6  | 10 pF Chip Capacitors, ATC               | Z3  | 0.362" x 1.260" Microstrip                               |
| C4      | 3.3 pF Chip Capacitor, ATC               | Z4  | 0.583" x 0.669" Microstrip                               |
| C5      | 4.7 pF Chip Capacitor, ATC               | Z5  | 0.449" x 0.179" Microstrip                               |
| C7, C8  | 100 nF Chip Capacitors, ACCU-P (1206)    | Z6  | 0.877" x 0.082" Microstrip                               |
| C9      | 3.9 pF Chip Capacitor, ATC               | Z7  | 0.326" x 0.082" Microstrip                               |
| C11     | 470 $\mu$ F, 63 V Electrolytic Capacitor | PCB | 0.030" Glass Teflon <sup>®</sup> ( $\epsilon_r = 2.55$ ) |
| R1, R2  | 1.0 k $\Omega$ Chip Resistors (0805)     |     |                                                          |
| R3      | 2 x 18 k $\Omega$ Chip Resistor (1206)   |     |                                                          |

**Figure 1. 1930 - 1990 MHz Test Fixture Schematic**

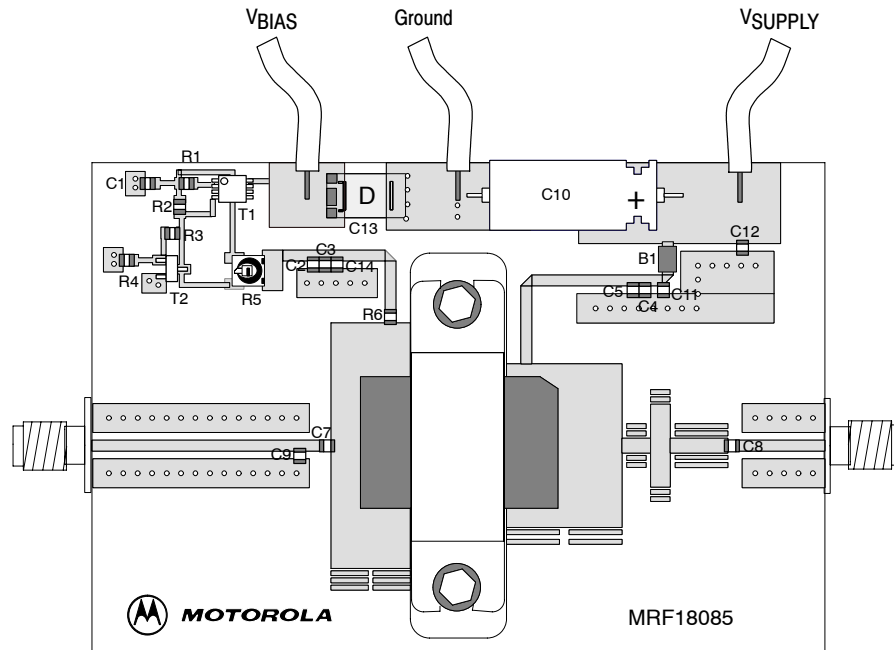


Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

**Figure 2. 1930 - 1990 MHz Test Fixture Component Layout**



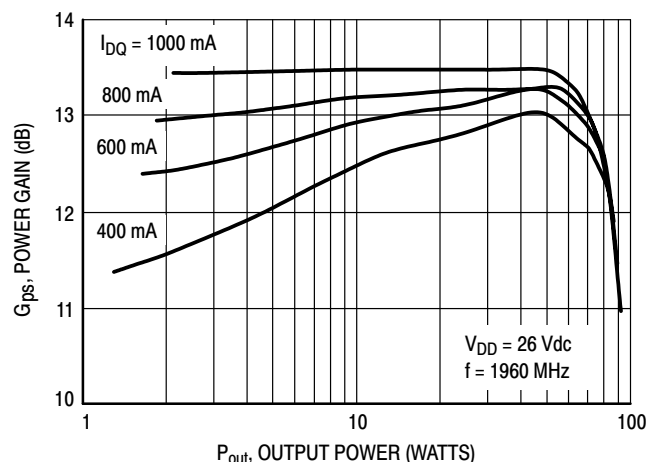
**Figure 3. 1930 - 1990 MHz GSM EDGE Optimized Demo Board Schematic**



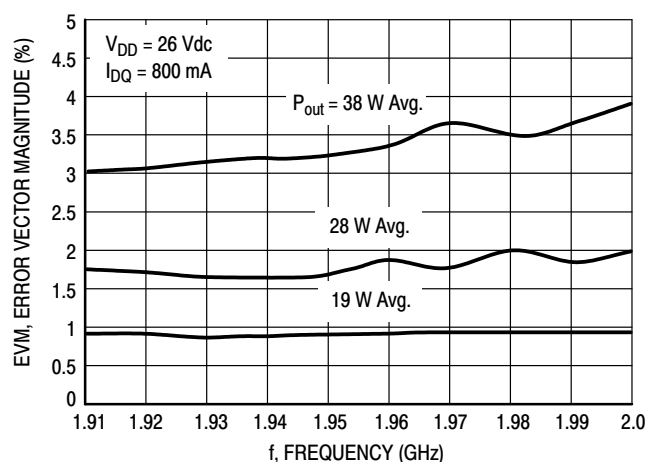
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**Figure 4. 1930 - 1990 MHz GSM EDGE Optimized Demo Board Component Layout**

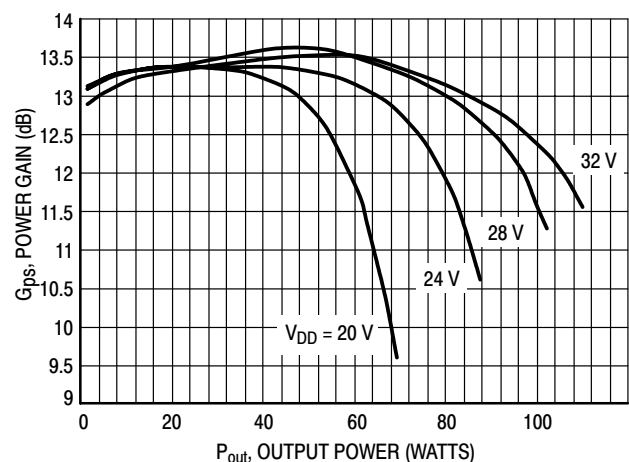
# **TYPICAL CHARACTERISTICS** (Performed on a GSM EDGE Optimized Demo Board)



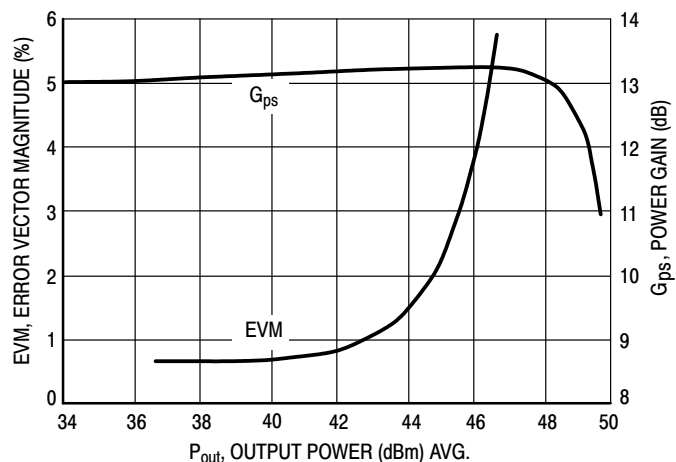
**Figure 5. Power Gain versus Output Power**



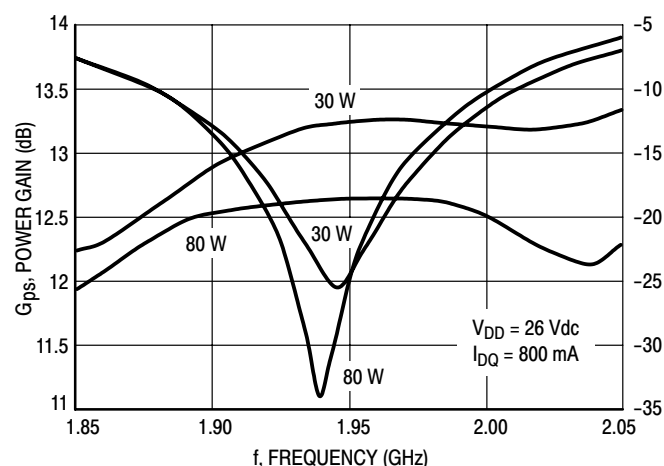
**Figure 6. Error Vector Magnitude versus Frequency**



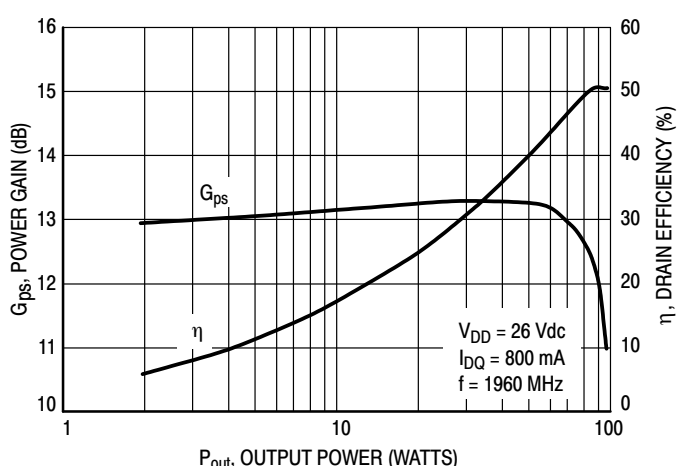
**Figure 7. Power Gain versus Output Power**



**Figure 8. EVM and Gain versus Output Power**



**Figure 9. Power Gain and IRL versus Frequency**



**Figure 10. Power Gain and Efficiency versus Output Power**

## GSM TEST SIGNAL

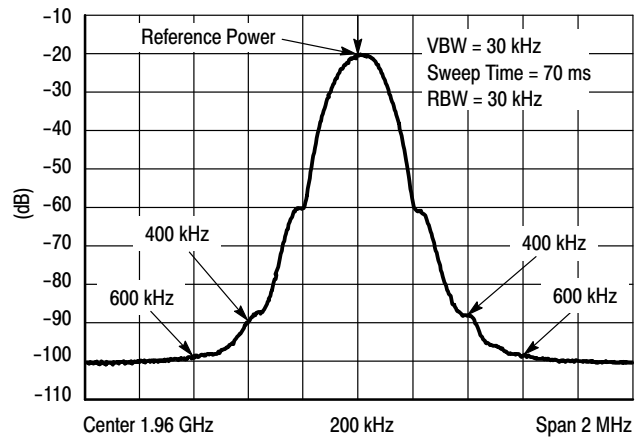
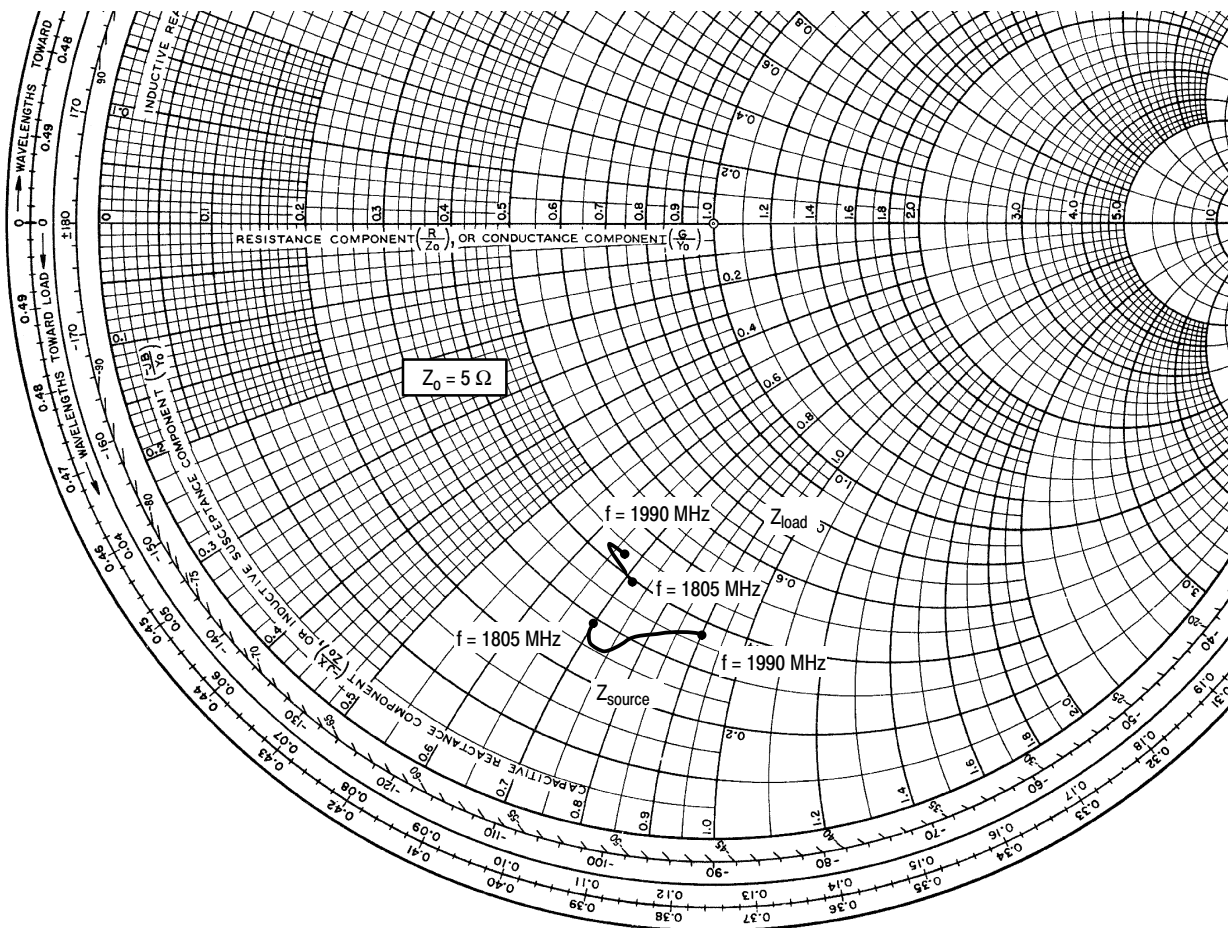


Figure 11. EDGE Spectrum



$V_{DD} = 26 \text{ V}$ ,  $I_{DQ} = 800 \text{ mA}$ ,  $P_{out} = 85 \text{ W CW}$

| f<br>MHz | $Z_{source}$<br>$\Omega$ | $Z_{load}$<br>$\Omega$ |
|----------|--------------------------|------------------------|
| 1805     | $1.43 - j3.74$           | $2 - j3.60$            |
| 1880     | $1.27 - j3.95$           | $1.98 - j3.57$         |
| 1930     | $1.5 - j4.13$            | $2.13 - j3.16$         |
| 1990     | $1.86 - j4.76$           | $2.17 - j3.36$         |

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

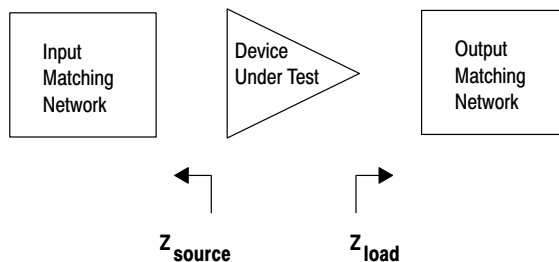


Figure 12. Series Equivalent Source and Load Impedance

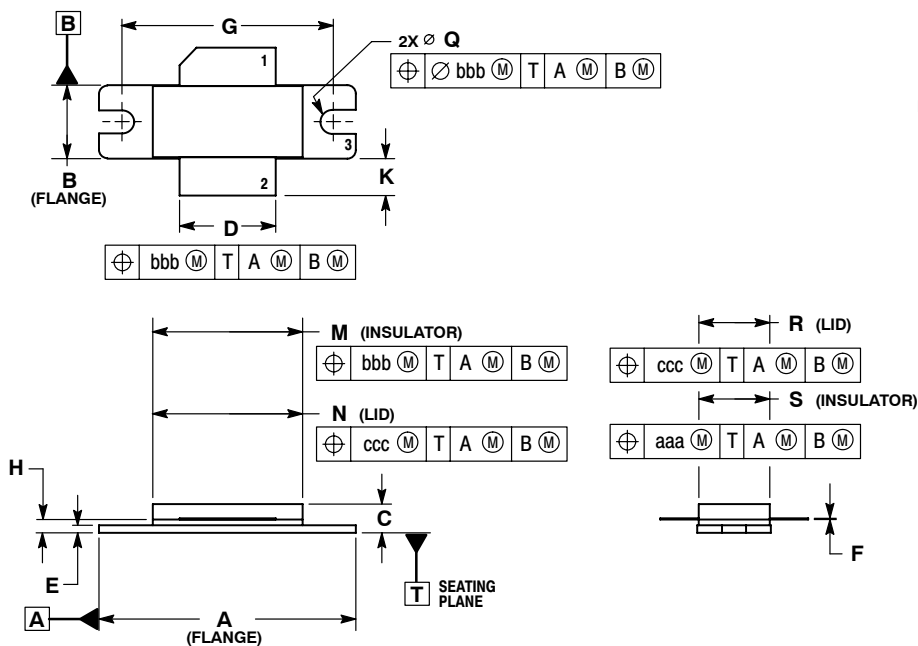


# NOTES



## NOTES

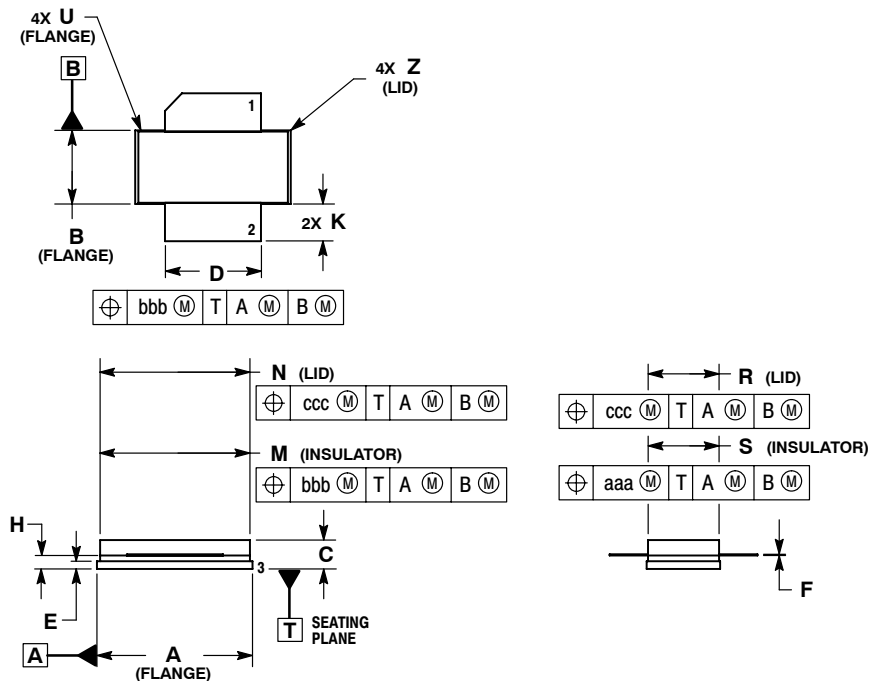
## PACKAGE DIMENSIONS



| DIM | INCHES              |                     | MILLIMETERS        |                    |
|-----|---------------------|---------------------|--------------------|--------------------|
|     | MIN                 | MAX                 | MIN                | MAX                |
| A   | 1.335               | 1.345               | 33.91              | 34.16              |
| B   | 0.380               | 0.390               | 9.65               | 9.91               |
| C   | 0.125               | 0.170               | 3.18               | 4.32               |
| D   | 0.495               | 0.505               | 12.57              | 12.83              |
| E   | 0.035               | 0.045               | 0.89               | 1.14               |
| F   | 0.003               | 0.006               | 0.08               | 0.15               |
| G   | 1.100 BSC           |                     | 27.94 BSC          |                    |
| H   | 0.057               | 0.067               | 1.45               | 1.70               |
| K   | 0.170               | 0.210               | 4.32               | 5.33               |
| M   | 0.774               | 0.786               | 19.66              | 19.96              |
| N   | 0.772               | 0.788               | 19.60              | 20.00              |
| Q   | $\varnothing$ 1.118 | $\varnothing$ 1.138 | $\varnothing$ 3.00 | $\varnothing$ 3.51 |
| R   | 0.365               | 0.375               | 9.27               | 9.53               |
| S   | 0.365               | 0.375               | 9.27               | 9.52               |
| aaa | 0.005 REF           |                     | 0.127 REF          |                    |
| bbb | 0.010 REF           |                     | 0.254 REF          |                    |
| ccc | 0.015 REF           |                     | 0.381 REF          |                    |

STYLE 1:  
PIN 1. DRAIN  
2. GATE  
3. SOURCE

**CASE 465-06  
ISSUE G  
NI-780  
MRF18085BLR3**



| DIM | INCHES    |       | MILLIMETERS |       |
|-----|-----------|-------|-------------|-------|
|     | MIN       | MAX   | MIN         | MAX   |
| A   | 0.805     | 0.815 | 20.45       | 20.70 |
| B   | 0.380     | 0.390 | 9.65        | 9.91  |
| C   | 0.125     | 0.170 | 3.18        | 4.32  |
| D   | 0.495     | 0.505 | 12.57       | 12.83 |
| E   | 0.035     | 0.045 | 0.89        | 1.14  |
| F   | 0.003     | 0.006 | 0.08        | 0.15  |
| H   | 0.057     | 0.067 | 1.45        | 1.70  |
| K   | 0.170     | 0.210 | 4.32        | 5.33  |
| M   | 0.774     | 0.786 | 19.61       | 20.02 |
| N   | 0.772     | 0.788 | 19.61       | 20.02 |
| R   | 0.365     | 0.375 | 9.27        | 9.53  |
| S   | 0.365     | 0.375 | 9.27        | 9.52  |
| U   | ---       | 0.040 | ---         | 1.02  |
| Z   | ---       | 0.030 | ---         | 0.76  |
| aaa | 0.005 REF |       | 0.127 REF   |       |
| bbb | 0.010 REF |       | 0.254 REF   |       |
| ccc | 0.015 REF |       | 0.381 REF   |       |

STYLE 1:  
PIN 1. DRAIN  
2. GATE  
5. SOURCE

**CASE 465A-06  
ISSUE H  
NI-780S  
MRF18085BLSR3**

**MRF18085BLR3 MRF18085BLSR3**

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